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IN THE CLAIMS

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- (Original)A sensing device comprising: a cantilever disposed with a medium which is movable relative to the cantilever; and a device a sociated with one of the cantilever and the medium which is responsive to changes in electrical field between the medium and the cantilever caused by a distance between the medium and the cantilever changing.
- (Original) A sensing device as set forth it claim 1, wherein the cantilever comprises a 2. probe which extends from the cantilever and contacts a surface of the medium having a topography that causes the distance between the cantilever and the medium to vary.
- (Original)A sensing device as set forth in claim 1, wherein the device is a FET (Field Effect 3. Transistor).
- (Original)A sensing device as set forth \dot{m} claim 1, wherein the device is an induced 4. channel FET (Field Effect Transistor).
- (Original)A sensing device as set forth in claim 3, wherein the medium is electrically non-5. conductive and is supported on a substrate which is electrically conductive, and wherein the substrate is circuited with the FET so that variations in the electrical field which result from a change in distance between the medium and the cantilever, induces a change in electrical current passing through the FET and produces a read signal.
- (Original) A read mechanism used in a contact atomic resolution storage system, 6. comprising: a cantilever disposed with an electi-ically non-conductive medium which is movable relative to the cantilever, the cantilever having a probe which follows a topography of the medium; and a device formed in the cantilever which responds to a change in electric field induced by a change in distance between the cantilever and a substrate on which the medium is supported.
- (Original) A read mechanism as set forth in claim 6, wherein the device is a FET (Field 7. Effect Transistor).
- (Original) A read mechanism as set forth in claim 6, wherein the device is an induced 8. channel FET (Field Effect Transistor).
- (Original)A read mechanism used in a contact atomic resolution storage system, 9. comprising: a cantilever disposed with a medium which is movable relative to the cantilever, the cantilever having a probe extending from the cantilever and in contact with a surface of an electrically conductive medium to follow changes in a data indicative topography of the medium;

a circuit which establishes an electrical connection between the cantilever and substrate on which the media is supported, and generates an electric field in a gap between the cantilever and the medium; and a device associated with the cantilever which is responsive to changes in the electric field in the air gap.

- 10. (Original) A read mechanism as set forth in claim 9, wherein the device is a FET (Field Effect Transistor).
- 11. (Original) A read mechanism as set forth in claim 9, wherein the device is an induced channel FET (Field Effect Transistor).
- (Original) A method of using a sensing device comprising: moving a probe supported on a cantilever relative to a medium that has a data indicative topography followed by the probe, the medium being associated with a substrate producing an electric field; and sensing the change in distance between the cantilever and the medium using a change in current flowing through a FET (Field Effect Transistor) formed in the cantilever, wherein the change in current is induced by a change in electric field between the substrate and the FET.
- 13. (Original)A method as set forth in 12, further comprising using the change in electric field to sense the presence of a bit of data which is written into the medium.
- 14. (Original)A method as set forth in 13, further comprising using the data bit sensing in a mass storage device.
- 15. (Withdrawn)A method of using a sensing device comprising; forming a FET in a first structure; generating an electric field in a second structure which is movable with respect to the first structure; and gating the FET using the electric field produced by the second structure and produce a signal indicative of the amount of separation between the first and second structures.
- 16. (Withdrawn) A method as set forth in claim 15, further comprising: controlling the relative position between the first structure and the second structure; and sensing data stored on the second structure using the signal indicative of the amount of separation between the first and second structures.
- 17. (Withdrawn)A method as set forth in claim 15, comprising using the device as a microphone.
- 18. (Withdrawn)A method as set forth in claim 15, further comprising using the device as an acceleration sensor.

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- 19. (Withdrawn) A method as set forth in claim 15, further comprising using the device as a pressure sensor.
- 20. (Withdrawn)A method as set forth in claim 15, further comprising using the device in a position control system.
- 21. (Withdrawn)A method of making a sensing device comprising: forming a cantilever; forming a FET (Field Effect Transistor) in the cantilever; forming an electrically non-conductive probe on the cantilever; and adapting the probe to follow a topography of a medium which is movable relative to the probe and which is associated with a substrate which is adapted to produce an electric field which acts as a gate for the FET.
- 22. (Withdrawn)A method as set forth in claim 21, further comprising: forming the medium of a thermoplastic electrically non-conductive material; forming the medium on the substrate; and forming the substrate of an electrically conductive material
- 23. (Withdrawn) A method as set forth in chaim 21, comprising forming the FET with a channel.
- 24. (Withdrawn)A method as set forth in claim 21, comprising forming the FET as a induced channel FET.
- 25. (Withdrawn) A method as set forth in Gaim 21, further comprising connecting the medium to a drive which moves the medium with respect to the probe.
- 26. (Original) A sensor device comprising: a cantilever, a medium which is movable with respect to the cantilever; electric field generation means disposed with a first of the cantilever and the medium for producing an electric field between the medium and the cantilever; and FET sensing means disposed with a second of the cantilever and the medium for responding to changes in an electric field induced by a change in clearance between the medium and the cantilever.
- 27. (Original)A sensor device as set forth in claim 26, further comprising probe means for detecting a data indicative topography of the medium and controlling the change in clearance between the cantilever and the medium.